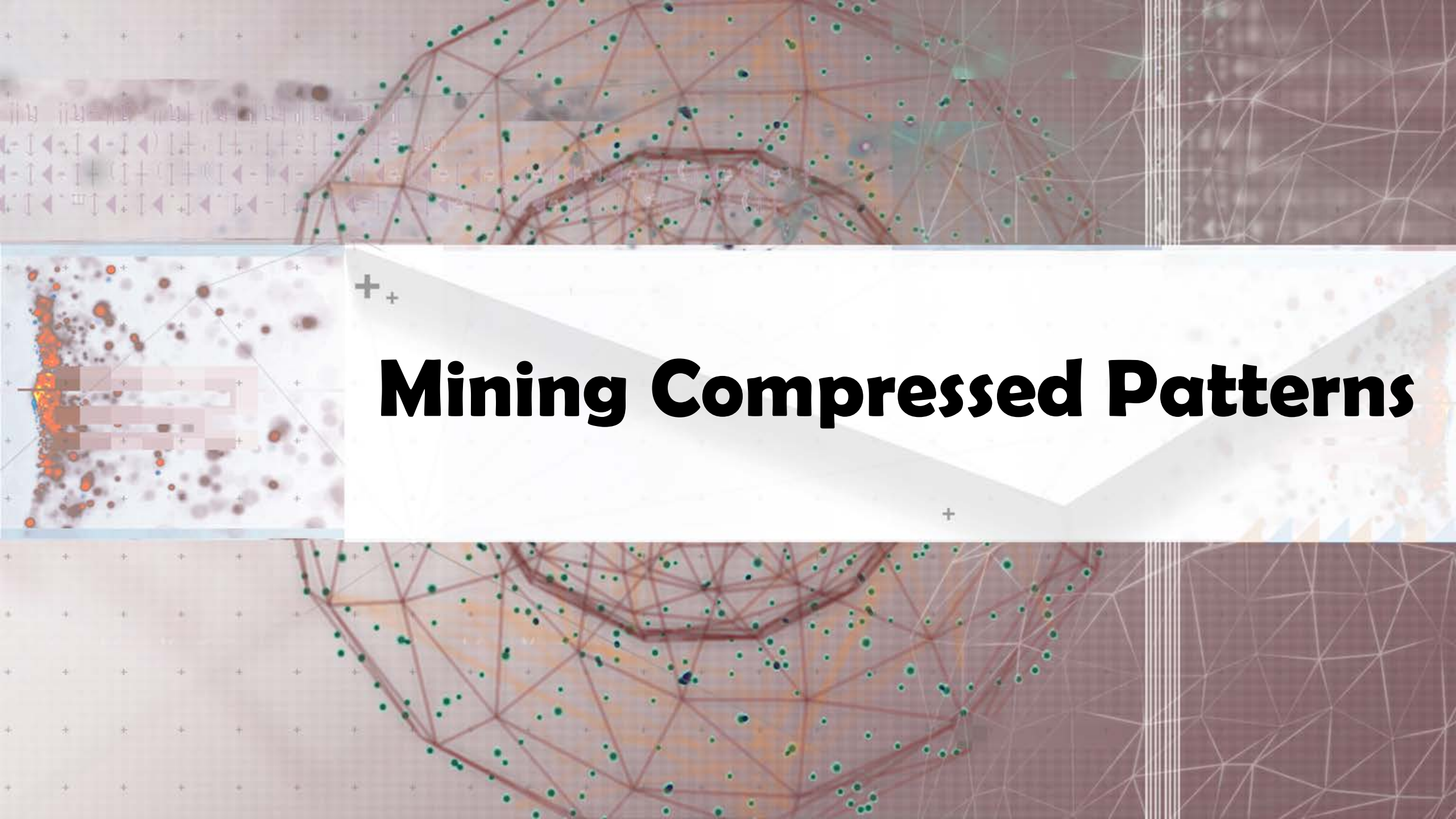


# Mining Compressed Patterns

# Mining Compressed Patterns

| Pat-ID | Item-Sets | Support |
|---|---|---|
| P1 | {38,16,18,12} | 205227 |
| P2 | {38,16,18,12,17} | 205211 |
| P3 | {39,38,16,18,12,17} | 101758 |
| P4 | {39,16,18,12,17} | 161563 |
| P5 | {39,16,18,12} | 161576 |

- Closed patterns
  - P1, P2, P3, P4, P5
  - Emphasizes too much on support
  - There is no compression
- Max-patterns
  - P3: information loss
- Desired output (a good balance):
  - P2, P3, P4

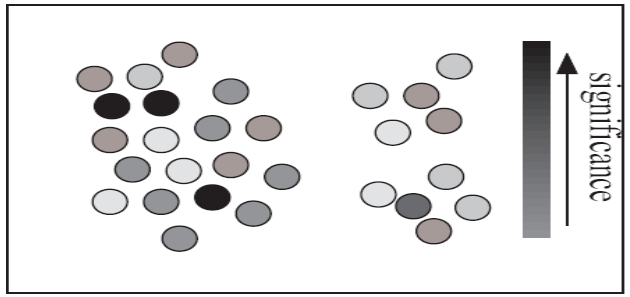
- Why mining compressed patterns?
  - Too many scattered patterns but not so meaningful
- Pattern distance measure

$$Dist(P_1, P_2) = 1 - \frac{|T(P_1) \cap T(P_2)|}{|T(P_1) \cup T(P_2)|}$$

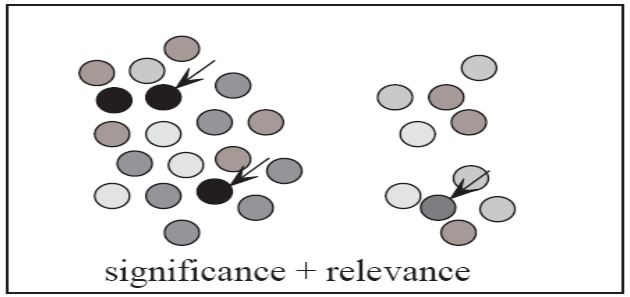
- δ-clustering: For each pattern P, find all patterns which can be expressed by P and whose distance to P is within δ (δ-cover)
- All patterns in the cluster can be represented by P
- Method for efficient, direct mining of compressed frequent patterns (e.g., D. Xin, J. Han, X. Yan, H. Cheng, "On Compressing Frequent Patterns", Knowledge and Data Engineering, 60:5-29, 2007)

# Redundancy-Aware Top-k Patterns

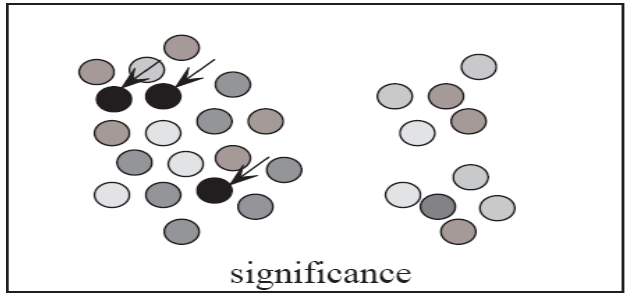
- Desired patterns: high significance & low redundancy



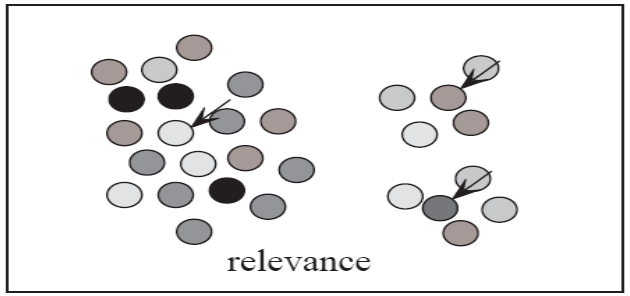

(a) a set of patterns




(b) redundancy-aware top-$k$

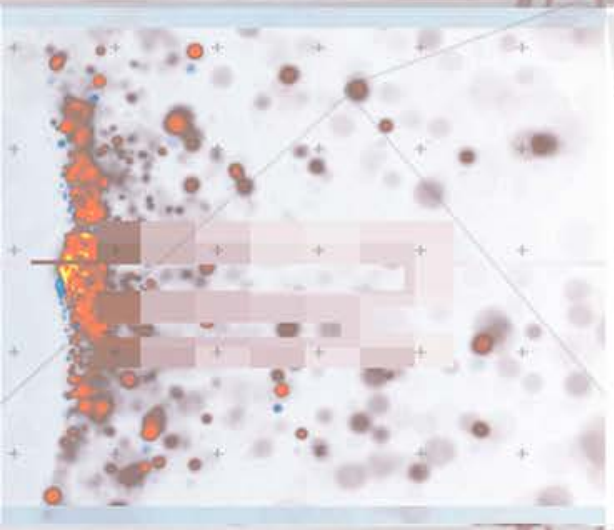



(c) traditional top-$k$




(d) summarization

- Method: Use MMS (Maximal Marginal Significance) for measuring the combined significance of a pattern set
- Xin et al., Extracting Redundancy-Aware Top-K Patterns, KDD'06



# Summary

# Summary: Mining Diverse Patterns

- Efficient methods have been developed for mining various kinds of patterns
  - Mining Multiple-Level Associations
  - Mining Multi-Dimensional Associations
  - Mining Quantitative Associations
  - Mining Negative Correlations
  - Mining Compressed and Redundancy-Aware Patterns

# Recommended Readings

- R. Srikant and R. Agrawal, “Mining generalized association rules”, VLDB'95
- Y. Aumann and Y. Lindell, “A Statistical Theory for Quantitative Association Rules”, KDD'99
- K. Wang, Y. He, J. Han, “Pushing Support Constraints Into Association Rules Mining”, IEEE Trans. Knowledge and Data Eng. 15(3): 642-658, 2003
- D. Xin, J. Han, X. Yan and H. Cheng, "On Compressing Frequent Patterns", Knowledge and Data Engineering, 60(1): 5-29, 2007
- D. Xin, H. Cheng, X. Yan, and J. Han, "Extracting Redundancy-Aware Top-K Patterns", KDD'06
- J. Han, H. Cheng, D. Xin, and X. Yan, "Frequent Pattern Mining: Current Status and Future Directions", Data Mining and Knowledge Discovery, 15(1): 55-86, 2007